Imputing Responses for Manufacturing Establishments Using a Mixed Model under a Matrix Sub-sample Design

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Sample Design



Subsample

Matrix Sample

- Manufacturing-focused
- Same stratum definitions
- Equal probability
- 50+ items



AIES = Annual Integrated Economic Survey NAICS = North American Industry Classification System

		Frame covariate	AIES core items		Matrix item
AIES Sampled Unit	Matrix Sample Indicator	MOS	ltem 1	ltem 2	ltem 3
1	1	<i>x</i> ₁	y_{11}	y_{21}	<i>z</i> ₁₁
2	0	<i>x</i> ₂	y_{12}	y_{22}	?
3	0	<i>x</i> ₃	<i>y</i> ₁₃	y_{23}	?
4	1	x_4	y_{14}	y_{24}	<i>z</i> ₁₄
5	1	<i>x</i> ₅	y_{15}	y_{25}	<i>z</i> ₁₅
6	0	<i>x</i> ₆	y_{16}	y_{26}	?
7	0	<i>x</i> ₇	y_{17}	y_{27}	?
8	0	<i>x</i> ₈	y_{18}	y_{28}	?
9	1	<i>x</i> 9	<i>Y</i> ₁₉	<i>y</i> ₂₉	<i>Z</i> ₁₉



Imputation approach

- 1. Fit a Bayesian linear mixed model using frame covariates and responses from the matrix sample
- 2. Impute responses for AIES units not selected in matrix sample
- 3. Compute estimates of domain totals

 Goal: have a lower root mean squared prediction error than design-based estimates

		Matrix item
AIES Sampled Unit	Matrix Sample Indicator	ltem 3
1	1	<i>z</i> ₁₁
2	0	<i>Z</i> ₁₂
3	0	<i>z</i> ₁₃
4	1	<i>Z</i> ₁₄
5	1	<i>Z</i> ₁₅
6	0	<i>Z</i> ₁₆
7	0	<i>Z</i> ₁₇
8	0	<i>Z</i> ₁₈
9	1	<i>Z</i> ₁₉



Challenges in model building

- Multiple outcome variables with complex relationships
- Frequent zero-valued observations in a some of the variables
- Highly skewed data
- Varying industry and geography estimation levels
- Need a model that is generalizable
 - Fit all (or most) outcomes
 - Handle zeros
 - Applicable across estimation levels



Items and outcome variables





EOY = End of year

Selected outcomes





BOY = Beginning of year EOY = End of year





Red lines = positive correlation Blue circle = frame covariate Yellow circle = AIES core items White circle = outcomes

Within NAICS4, each matrix item is independently model as

$$\log z_{vsji} = \beta_0 + \beta_1 \log x_i + \beta_2 \log y_{3i} + \beta_3 \log y_{4i} + \gamma_s + \delta_j + \epsilon_i$$

• z_{vsji} = response of v^{th} matrix item for establishment *i* in state *s* operating in NAICS6 industry *j*



Within NAICS4

$$\log z_{vsji} = \beta_0 + \beta_1 \log x_i + \beta_2 \log y_{3i} + \beta_3 \log y_{4i} + \gamma_s + \delta_j + \epsilon_i$$

• Linear regression modeling a national relationship between response and frame covariate MOS



Within NAICS4

$$\log z_{vsji} = \beta_0 + \beta_1 \log x_i + \beta_2 \log y_{3i} + \beta_3 \log y_{4i} + \gamma_s + \delta_j + \epsilon_i$$

• Linear regression modeling a national relationship between response and AIES core items of receipts and employment



Within NAICS4

$$\log z_{vsji} = \beta_0 + \beta_1 \log x_i + \beta_2 \log y_{3i} + \beta_3 \log y_{4i} + \gamma_s + \delta_j + \epsilon_i$$
$$\gamma_s \sim N(0, \sigma_s^2)$$

• Random effect for state allowing deviation from the national trend



Within NAICS4

$$\log z_{vsji} = \beta_0 + \beta_1 \log x_i + \beta_2 \log y_{3i} + \beta_3 \log y_{4i} + \gamma_s + \delta_j + \epsilon_i$$
$$\delta_j \sim N(0, \sigma_j^2)$$

 Random effect for NAICS6 industry allowing deviation from national NAICS4 industry trend



Within NAICS4

$$\log z_{vsji} = \beta_0 + \beta_1 \log x_i + \beta_2 \log y_{3i} + \beta_3 \log y_{4i} + \gamma_s + \delta_j + \epsilon_i$$
$$\epsilon_i \sim N(0, \sigma_i^2)$$

• Residual error



Simulation

- Generate 1000 samples from research frame following the AIES and matrix sample designs
- Fit full linear mixed model to impute missing responses
 - Use maximum likelihood approximation
- Calculate domain estimates $\hat{\theta}^d$ with a ratio estimator
 - Domain = NAICS4 x state
- Showing results for single NAICS4 industry



Evaluation Criteria

Relative absolute bias (RAB)

$$\text{RAB} = \frac{1}{1000} \sum_{r}^{} \frac{\left| \hat{\theta}_{r}^{d} - \theta_{r}^{d} \right|}{\theta_{r}^{d}}$$

Reduction in root mean-squared prediction-error (RMSPE)

$$\text{RMSPE} = \sqrt{\frac{1}{1000} \sum_{r} \left(\hat{\theta}_{r}^{d} - \theta_{r}^{d}\right)^{2}}$$

 $Reduction = \frac{RMSPE_{model}}{RMSPE_{designed}}$



















Note: y-axis is truncated









Empirical Application

- Take a sample from production frame following AIES and matrix sample designs
- Fit full linear mixed model
 - Use Bayesian imputation model
 - Implemented with "Stan" in R
- Obtain posterior distribution of estimated domain totals
 - Back-transform variable and ratio adjust totals
 - Domain = naics4 x state
- Compare with design-based ratio estimate and true domain total







Discussion

- Work in progress but promising results
 - Generally comparable or lower bias for most variables
 - Generally lower MSE for most variables
 - Can produce estimates for small domains with no observable data
- Future research
 - Improve prediction for variables with high percentage of zeros
 - Predicting zeros first and then positive values
 - Produce estimates for detailed items
 - Combining sampling variability and imputation variability
 - Evaluate whether variable should be included in short-form survey



Thank you!

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